



SPECIFICATION

PN: SJK-6B07372MBZ1210A6

深圳市晶科鑫实业有限公司

SHENZHEN CRYSTAL TECHNOLOGY INDUSTRIAL CO., LTD.

VER	DESIGNED	CHECKED	APPROVED
A1	邵丹斌	李相同	刘忠亮

CUSTOMER APPROVAL

SPECIFICATION :	晶振 / 49S / 7.3728MHz		
SJK PN. :	SJK-6B07372MBZ1210A6		
CUSTOMER PN. :			
CHECKED 1	CHECKED 2	APPROVED	DATE
Result: ☐ PASS ☐ FAIL ☐ OTHER			

FEATURE

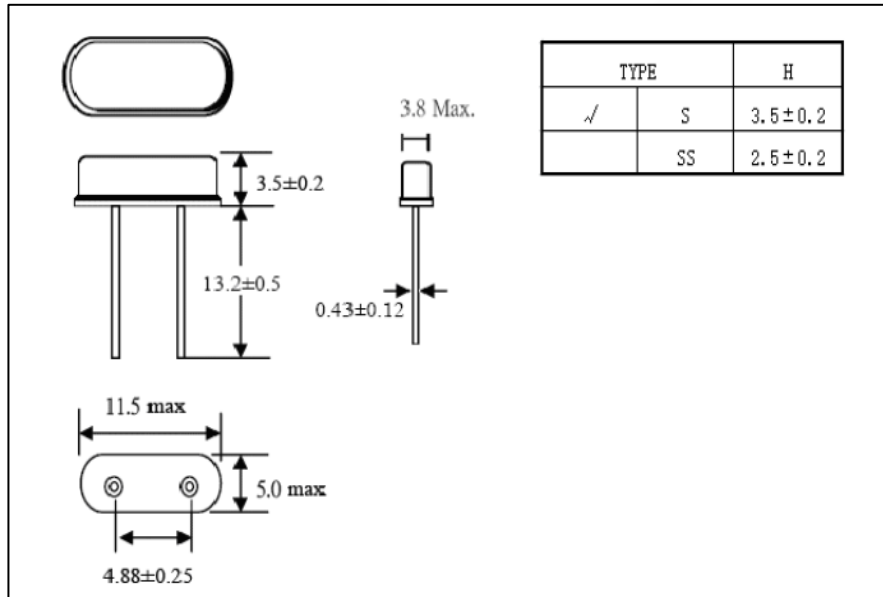
- Surface mount type crystal units.
- A great number of standard frequencies.
- Higher frequency pullability and lower equivalent series resistance.
- Highly mass production capability.
- The best choice of TV,STB,LCDM and Cable Modem.
- RoHS Compliant/Pb Free.

ELECTRICAL SPECIFICATIONS

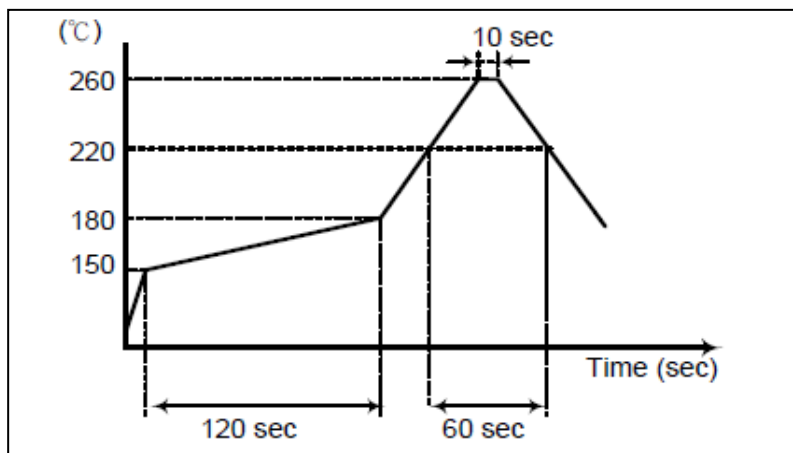
Nominal Frequency	7.3728MHz
Mode	Fundamental
Frequency Tolerance (at 25°C)	±10ppm
Frequency Stability Over Operating Temperature Characteristics	±10ppm
Operating Temperature Range	-20°C to +70°C
Storage Temperature Range	-55°C to +125°C
Shunt Capacitance (C0)	≤7.0 PF Max
Driver Level (DL)	100μW Typical
Load Capacitance(CL)	20PF
Equivalent Series Resistance(ESR)	80Ω Max
Insulation resistance	More than 500MΩ AT DC100V
Aging @25°C first year (Max)	±3ppm/year

REMARK: SPECIFICATIONS SUBJECT TO CHANGE WITHOUT PRIOR NOTICE,
PLEASE CONFIRM WITH OUR SALES ENGINEER.

DIMENSION (Unit: mm)



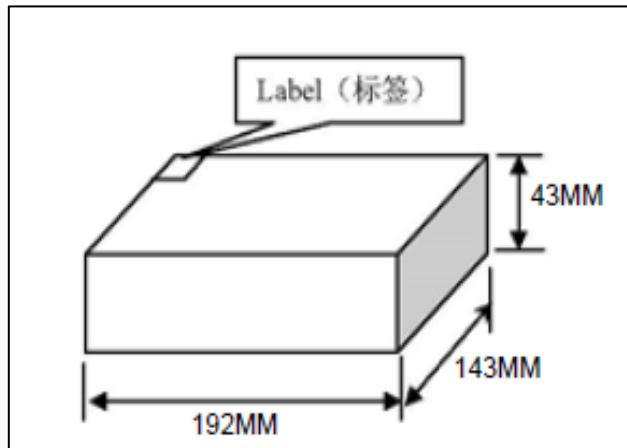
REFLOW CONDITION



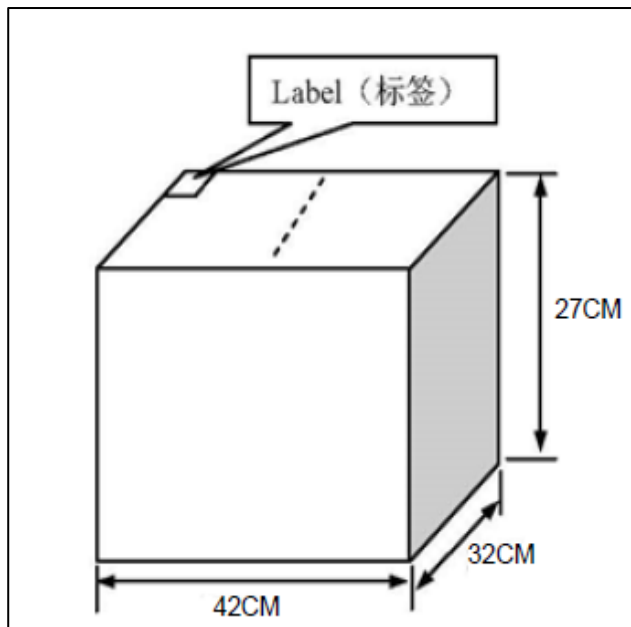
The reflow temperature profile may vary depending on the product model, specifications and frequency range. Refer to the individual product specifications for details

PACKING METHOD

Box: Packed 200PCS in 1 vinyl bag. Packed 5 vinyl bag in 1 box



Carton: Packed 20 box in 1 carton, There are 20000Pcs in 1 carton.



RELIABILITY TEST SPECIFICATIONS

Test item	Equipment	Condition	Specification
1.SOLDERABILITY TEST	SJK-REL001、RC-328A	TP:260℃ TsMax: 200℃ TsMin: 150℃ 2 time 	MIL-STD-883E Method 2003.7
2. HERMETICITY TEST	HELIOT-306S	Pressurized 0.4~0.5Mpa ethanol sealed tank for 10 minutes	MIL-STD-883E Method 1014.10
3. VIBRATION TEST	HG-V4、S&A 250B	Enable Crystal(10g) from 10-55-10Hz,X、Y、Z horizontal,1 Minute vibration/time, 1time/ 2 hours.	MIL-STD-883E Method 2007.3
4. MECHANICAL SHOCK	HPC-200、S&A 250B	Enable Crystal 50G(490m/s ²) time=11 ms speed=3.4 m/s half sine wave oscillation	JIS C6701
5. DROP TEST	HARD BOARD.S&A250B	75cm High,3 times on hard board	MIL-STD-202F Method 213B
6. HIGH&LOW TEMP STORAGE TEST(Static test)	H-PTH-80CK & HM101-3ABN, S&A 350B/250B	High temperature: 125℃±2℃,1000hr; Low temperature:-40℃±3℃,1000hrs	MIL-STD883C, METHOD 1011.8
7. TEMP & HUM CYCLING TEST	H-PTH-80CK CHAMBE, S&A 350B/250B	Temperature:-10℃±2℃~65℃±2℃,Humidity:93±3%,1 cycle need 24 hrs. 5cycles.	MIL-STD-883E Method 1005.8
8. HIGH TEM. & HUM.STORAGE TEST	H-PTH-80CK CHAMBE, S&A350B/250B	Temperature:85℃±2, Humidity:85+3,-2%,Store 96 hrs	JIS C6701
9. AGING TEST	H-PTH-80CK CHAMBE, S&A350B/250	Temperature:85℃±2, Store 1000 hrs	JIS C5023

REVISION RECORD (SJK-6B07372MBZ1210A6)

Rev	Revise contents	Reason	Reviser	Checked	Approved
A1	Initial released	--	贺丹斌	李相同	刘惠光